




Search Notes 	Application/Control No. 10605796	Applicant(s)/Patent Under Reexamination CHIU ET AL.
	Examiner Moore, Patrick M	Art Unit 2188

Notes	Date	Examiner
Text Search for "LUN" and "LBA" within closest possible references	05/25/2006	PMM
Updated Classification Search (711/112,216,159,206,220,221; 710/3,5; 707/203;) and narrowed with original text search	05/25/2006	PMM
Updated Text Searches for Newly Issued Patents	05/25/2006	PMM
Interference Search [see: S69 and S70]	05/25/2006	PMM
Discussed Applicant's arguments and state of prior art with Primary Examiner [Gary Portka]	05/25/2006	PMM
U.S. Patent and Trademark Office		Part of Paper No.: 20050525

<i>Interference Searched</i> 	Application/Control No. 10605796	Applicant(s)/Patent Under Reexamination CHIU ET AL.
	Examiner Moore, Patrick M	Art Unit 2188

Class	SubClass	Date	Examiner
-------	----------	------	----------

U.S. Patent and Trademark Office	Part of Paper No.: 20050525
----------------------------------	-----------------------------

<p>Searched</p> 	<p>Application/Control No.</p> <p>10605796</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>CHIU ET AL.</p>
	<p>Examiner</p> <p>Moore, Patrick M</p>	<p>Art Unit</p> <p>2188</p>

Class	SubClass	Date	Examiner
-------	----------	------	----------

U.S. Patent and Trademark Office	Part of Paper No.: 20050525
----------------------------------	-----------------------------